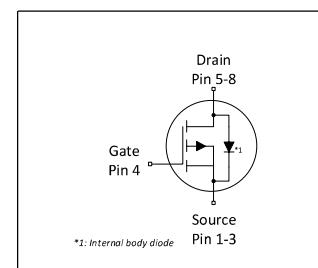


# MOSFET

## OptiMOS™ 3 Power-MOSFET, 30 V

### Features

- Fast switching MOSFET for SMPS
- Optimized technology for DC/DC converters
- Qualified according to JEDEC<sup>1)</sup> for target applications
- N-channel; Logic level
- Excellent gate charge x  $R_{DS(on)}$  product (FOM)
- Very low on-resistance  $R_{DS(on)}$
- Superior thermal resistance
- Avalanche rated
- Pb-free plating; RoHS compliant; Halogen Free
- Halogen-free according to IEC61249-2-21



**Table 1 Key Performance Parameters**

Parameter	Value	Unit
$V_{DS}$	30	V
$R_{DS(on),max}$	5.8	$\text{m}\Omega$
$I_D$	71	A

Type / Ordering Code	Package	Marking	Related Links
BSZ058N03LS G	PG-TSDSON-8	058N03L	-

<sup>1)</sup> J-STD20 and JESD22

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## 1 Maximum ratings

at  $T_A=25$  °C, unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	71	A	$V_{GS}=10$ V, $T_C=25$ °C
		-	-	45		$V_{GS}=10$ V, $T_C=100$ °C
		-	-	57		$V_{GS}=4.5$ V, $T_C=25$ °C
		-	-	36		$V_{GS}=4.5$ V, $T_C=100$ °C
		-	-	15		$V_{GS}=10$ V, $T_A=25$ °C, $R_{thJA}=60$ K/W <sup>2)</sup>
Pulsed drain current <sup>3)</sup>	$I_{D,pulse}$	-	-	284	A	$T_C=25$ °C
Avalanche current, single pulse <sup>4)</sup>	$I_{AS}$	-	-	20	A	$T_C=25$ °C
Avalanche energy, single pulse	$E_{AS}$	-	-	55	mJ	$I_D=20$ A, $R_{GS}=25$ Ω
Reverse diode dv/dt	dv/dt	-	-	6	kV/μs	$I_D=40$ A, $V_{DS}=24$ V, $di/dt=200$ A/μs, $T_{j,max}=150$ °C
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	45	W	$T_C=25$ °C
		-	-	2.1		$T_A=25$ °C, $R_{thJA}=60$ K/W <sup>2)</sup>
Operating and storage temperature	$T_j$ , $T_{stg}$	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	$R_{thJC}$	-	-	2.8	K/W	-
Device on PCB, 6 cm <sup>2</sup> cooling area <sup>2)</sup>	$R_{thJA}$	-	-	60	K/W	-

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> See figure 3 for more detailed information

<sup>4)</sup> See figure 13 for more detailed information

### 3 Electrical characteristics

at  $T_j=25$  °C, unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	30	-	-	V	$V_{GS}=0$ V, $I_D=1$ mA
Gate threshold voltage	$V_{GS(\text{th})}$	1	-	2.2	V	$V_{DS}=V_{GS}$ , $I_D=250$ µA
Zero gate voltage drain current	$I_{DSS}$	-	0.1 10	1 100	µA	$V_{DS}=30$ V, $V_{GS}=0$ V, $T_j=25$ °C $V_{DS}=30$ V, $V_{GS}=0$ V, $T_j=125$ °C
Gate-source leakage current	$I_{GSS}$	-	10	100	nA	$V_{GS}=20$ V, $V_{DS}=0$ V
Drain-source on-state resistance	$R_{DS(\text{on})}$	-	7.1 4.8	8.9 5.8	mΩ	$V_{GS}=4.5$ V, $I_D=20$ A $V_{GS}=10$ V, $I_D=20$ A
Gate resistance	$R_G$	0.6	1.3	2.3	Ω	-
Transconductance	$g_{fs}$	36	71	-	S	$ V_{DS} >2 I_D R_{DS(\text{on})\text{max}}$ , $I_D=30$ A

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance <sup>1)</sup>	$C_{iss}$	-	1800	2400	pF	$V_{GS}=0$ V, $V_{DS}=15$ V, $f=1$ MHz
Output capacitance <sup>1)</sup>	$C_{oss}$	-	690	920	pF	$V_{GS}=0$ V, $V_{DS}=15$ V, $f=1$ MHz
Reverse transfer capacitance	$C_{rss}$	-	36	-	pF	$V_{GS}=0$ V, $V_{DS}=15$ V, $f=1$ MHz
Turn-on delay time	$t_{d(\text{on})}$	-	4.6	-	ns	$V_{DD}=15$ V, $V_{GS}=10$ V, $I_D=30$ A, $R_G=1.6$ Ω
Rise time	$t_r$	-	3.6	-	ns	$V_{DD}=15$ V, $V_{GS}=10$ V, $I_D=30$ A, $R_G=1.6$ Ω
Turn-off delay time	$t_{d(\text{off})}$	-	19	-	ns	$V_{DD}=15$ V, $V_{GS}=10$ V, $I_D=30$ A, $R_G=1.6$ Ω
Fall time	$t_f$	-	3.2	-	ns	$V_{DD}=15$ V, $V_{GS}=10$ V, $I_D=30$ A, $R_G=1.6$ Ω

**Table 6 Gate charge characteristics<sup>2)</sup>**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	$Q_{gs}$	-	5.5	7.4	nC	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Gate charge at threshold	$Q_{g(\text{th})}$	-	2.8	3.7	nC	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Gate to drain charge <sup>1)</sup>	$Q_{gd}$	-	2.5	4.2	nC	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Switching charge	$Q_{sw}$	-	5.3	7.9	nC	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Gate charge total <sup>1)</sup>	$Q_g$	-	11	14	nC	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Gate plateau voltage	$V_{\text{plateau}}$	-	3.2	-	V	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 4.5 V
Gate charge total	$Q_g$	-	22	30	-	$V_{DD}=15$ V, $I_D=30$ A, $V_{GS}=0$ to 10 V
Gate charge total, sync. FET	$Q_{g(\text{sync})}$	-	9	13	nC	$V_{DS}=0.1$ V, $V_{GS}=0$ to 4.5 V
Output charge	$Q_{oss}$	-	18	24	-	$V_{DD}=15$ V, $V_{GS}=0$ V

<sup>1)</sup> Defined by design. Not subjected to production test

<sup>2)</sup> See "Gate charge waveforms" for parameter definition

Table 7 Reverse diode

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	$I_S$	-	-	41	A	$T_C=25\text{ }^\circ\text{C}$
Diode pulse current	$I_{S,pulse}$	-	-	284	A	$T_C=25\text{ }^\circ\text{C}$
Diode forward voltage	$V_{SD}$	-	0.83	1.1	V	$V_{GS}=0\text{ V}$ , $I_F=20\text{ A}$ , $T_j=25\text{ }^\circ\text{C}$
Reverse recovery charge	$Q_{rr}$	-	-	10	nC	$V_R=15\text{ V}$ , $I_F=I_S$ , $di_F/dt=400\text{ A}/\mu\text{s}$

## 4 Electrical characteristics diagrams

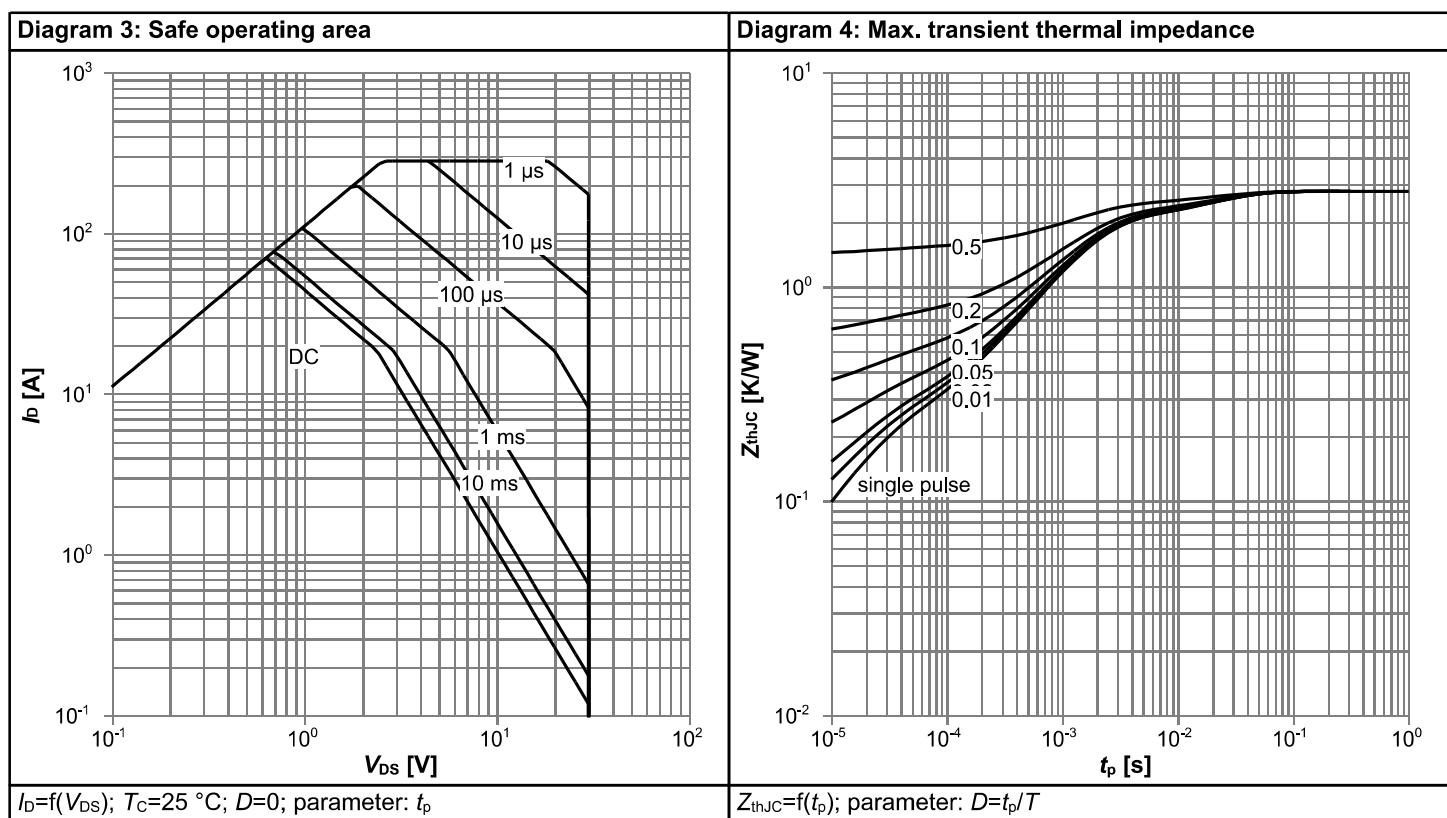
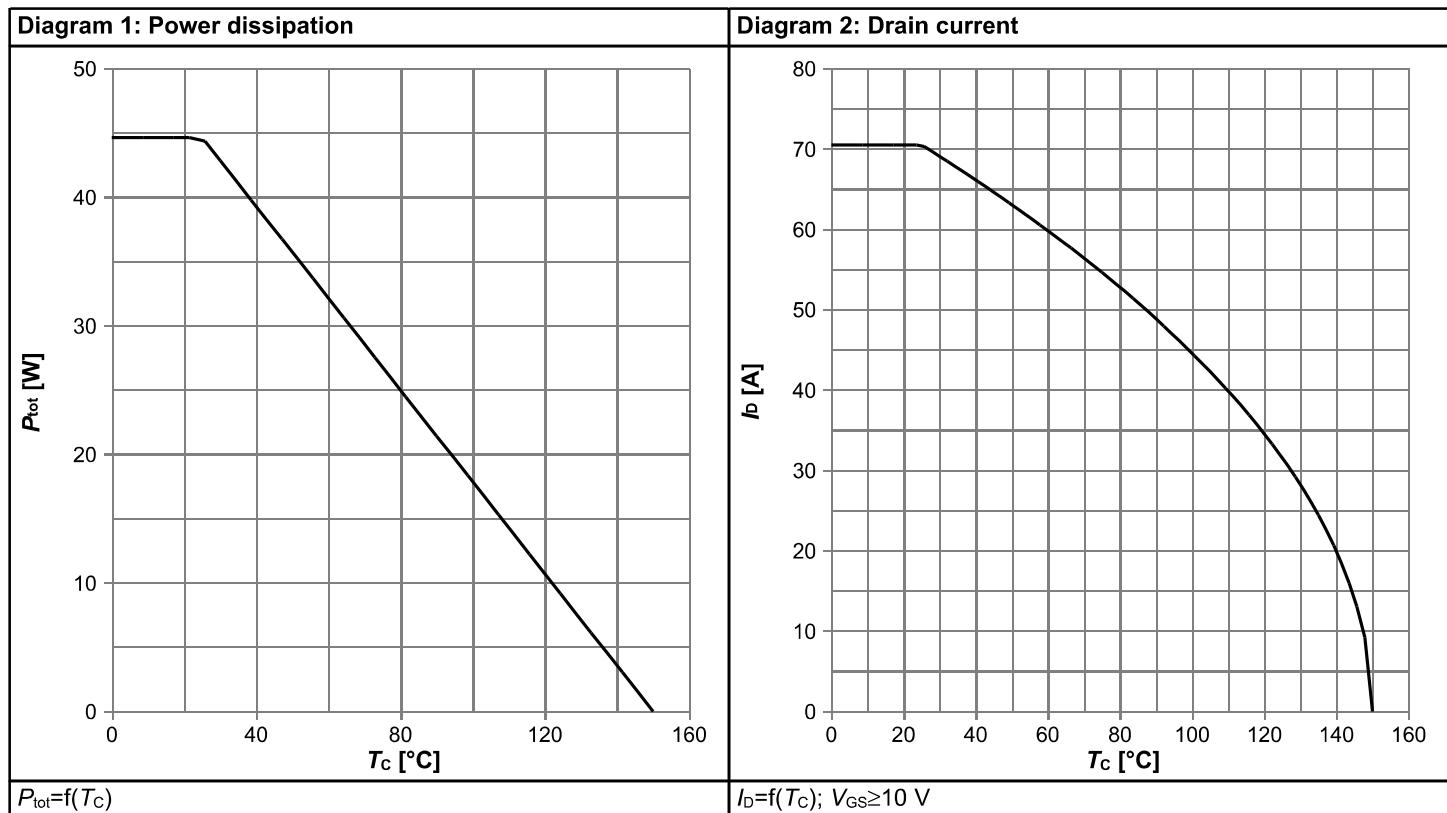
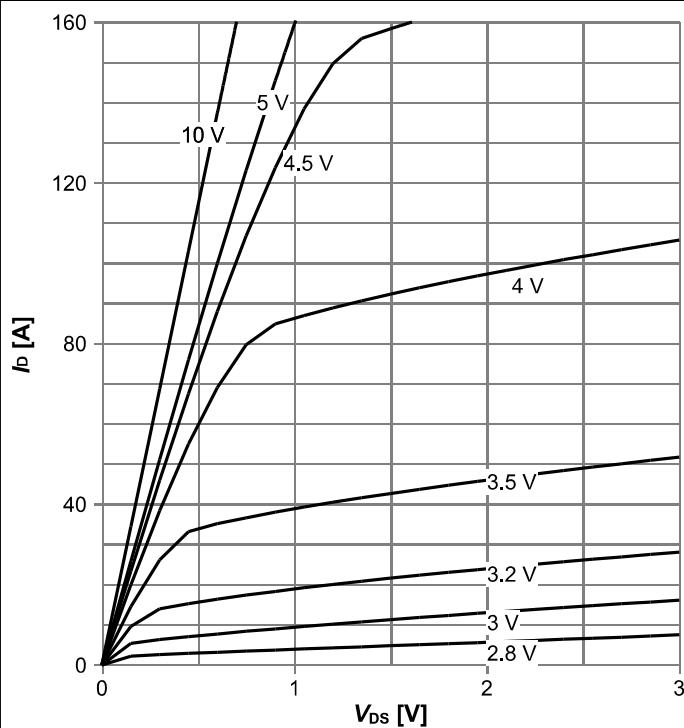
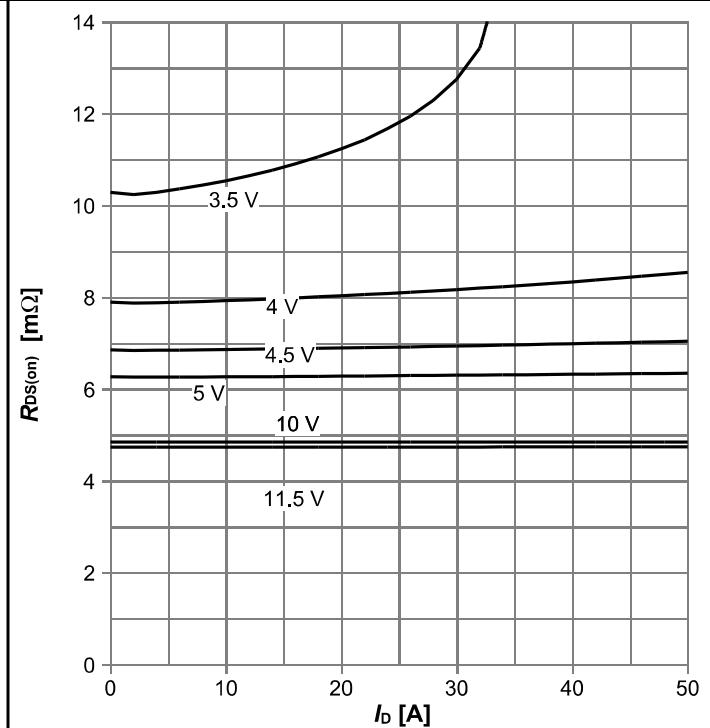


Diagram 5: Typ. output characteristics



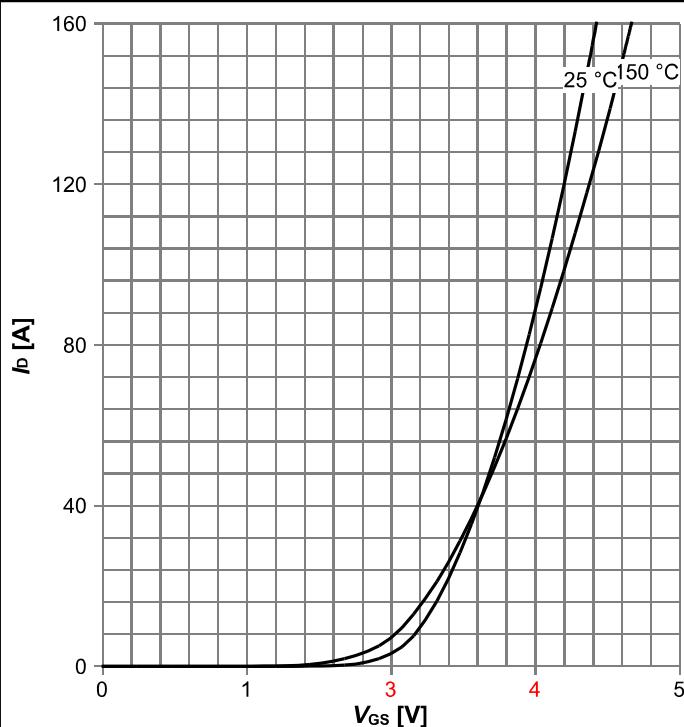
$I_D=f(V_{DS})$ ;  $T_j=25\text{ }^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 6: Typ. drain-source on resistance



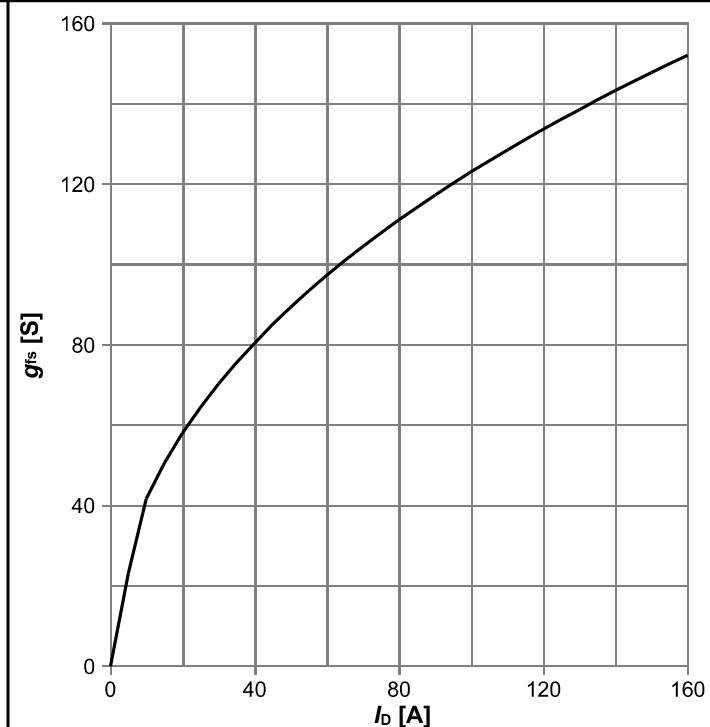
$R_{DS(on)}=f(I_D)$ ;  $T_j=25\text{ }^\circ\text{C}$ ; parameter:  $V_{GS}$

Diagram 7: Typ. transfer characteristics



$I_D=f(V_{GS})$ ,  $|V_{DS}|>2|I_D|R_{DS(on)max}$ ; parameter:  $T_j$

Diagram 8: Typ. forward transconductance



$g_{fs}=f(I_D)$ ;  $T_j=25\text{ }^\circ\text{C}$

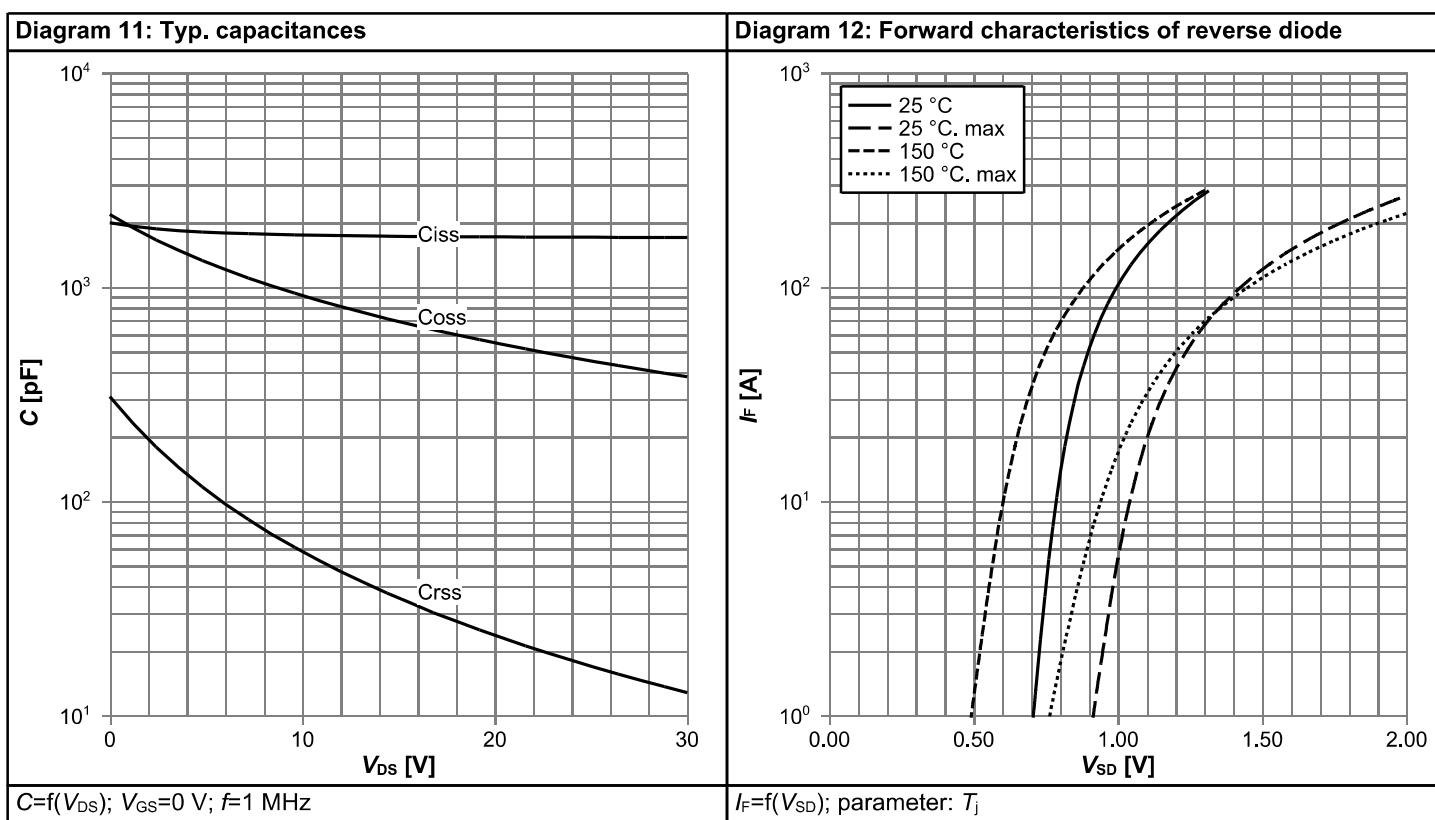
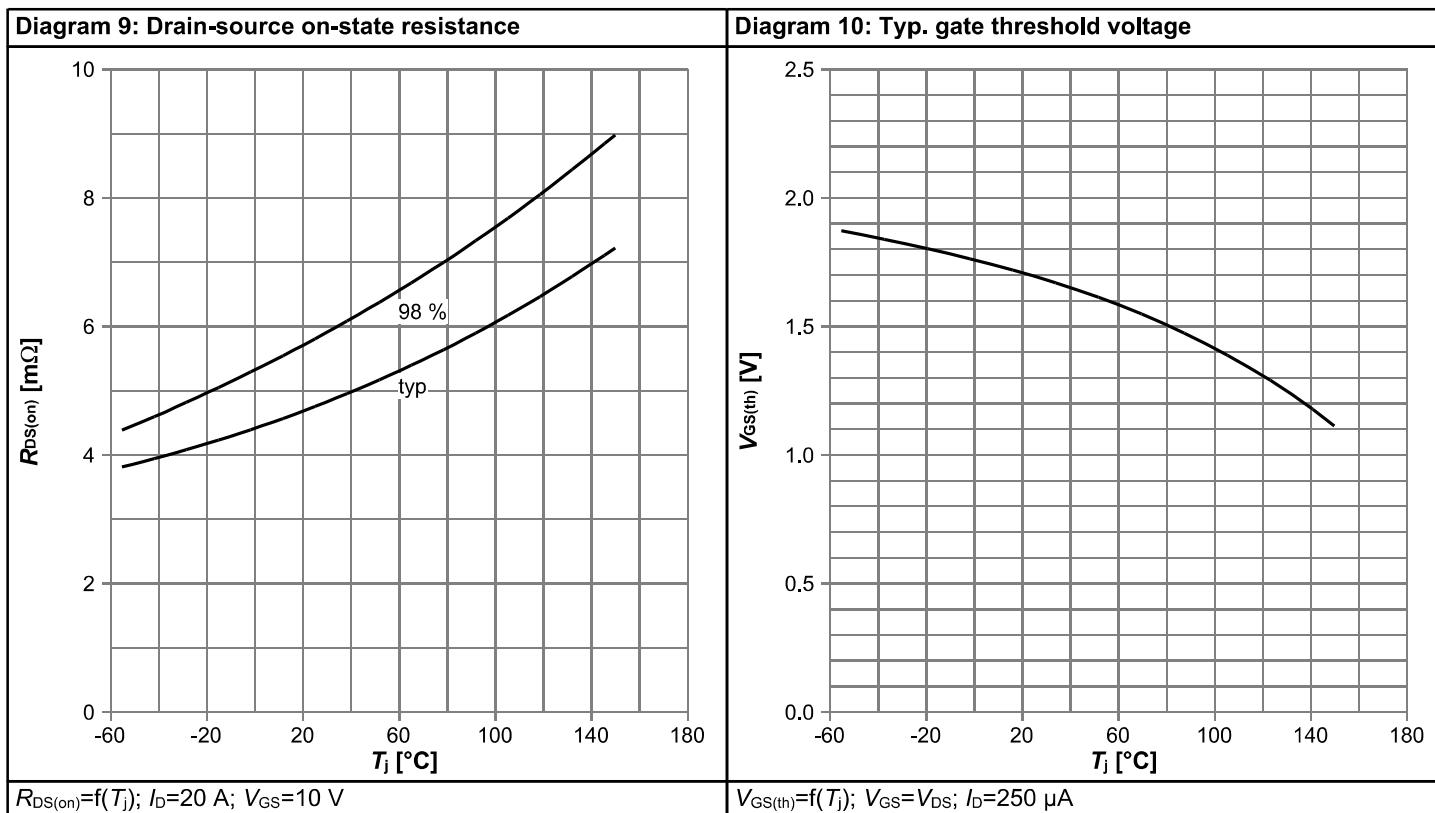
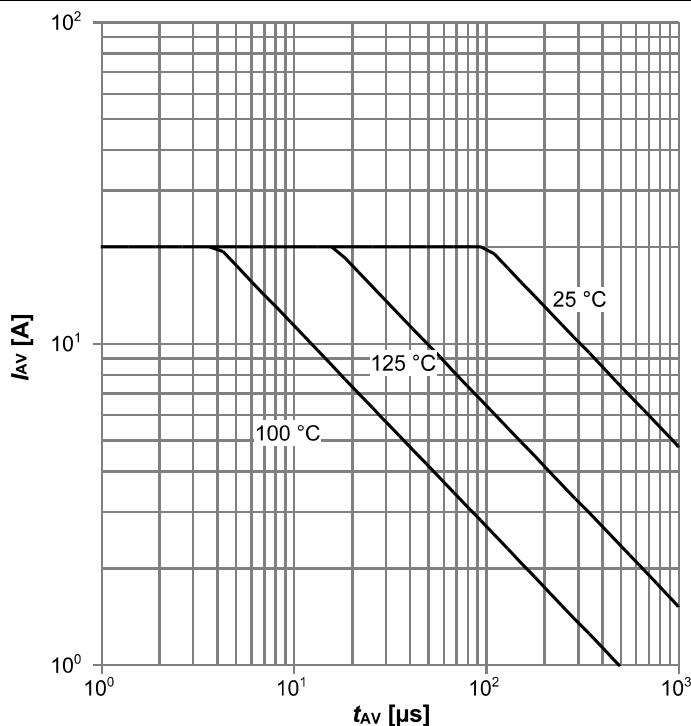
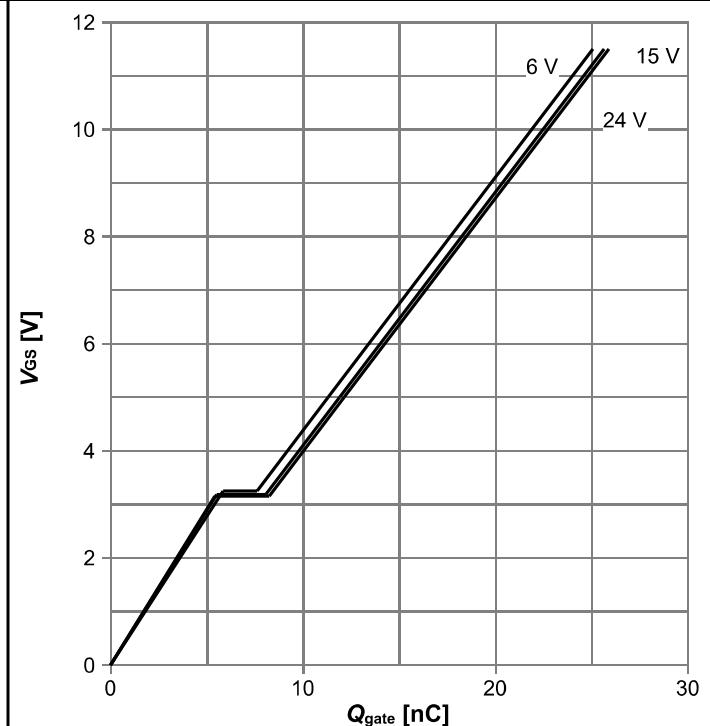


Diagram 13: Avalanche characteristics



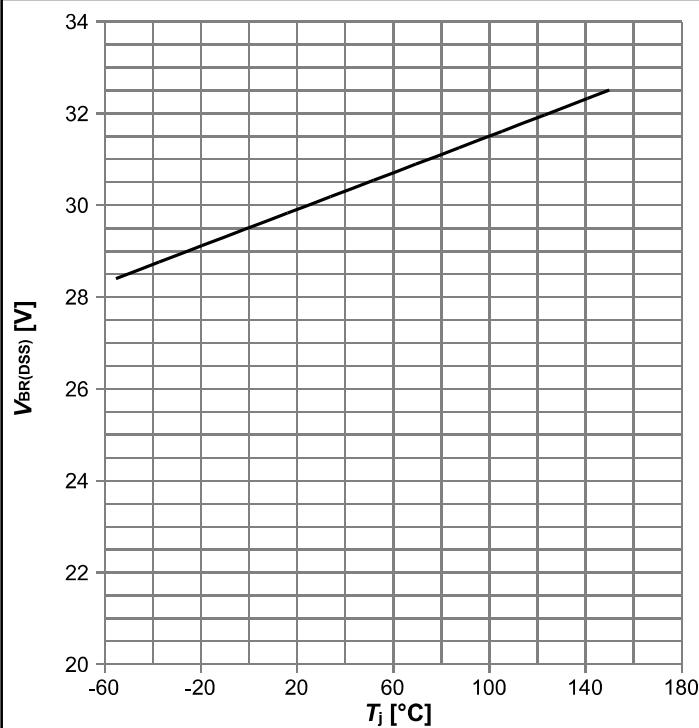
$I_{AS}=f(t_{AV})$ ;  $R_{GS}=25 \Omega$ ; parameter:  $T_{j(start)}$

Diagram 14: Typ. gate charge



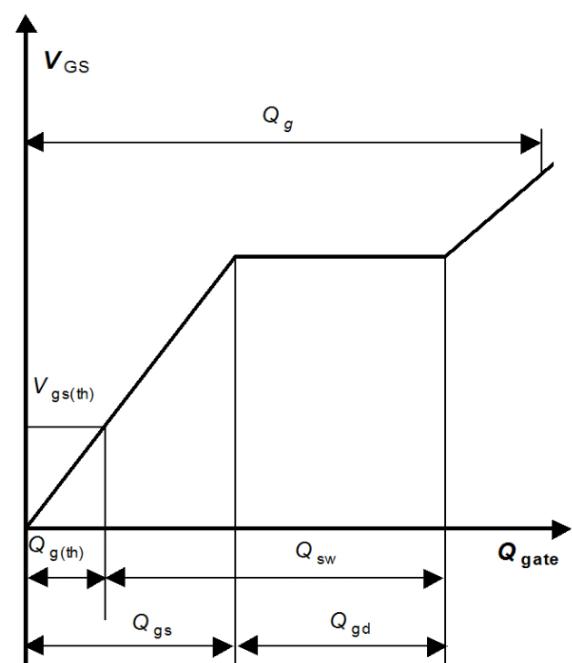
$V_{GS}=f(Q_{gate})$ ;  $I_D=30$  A pulsed; parameter:  $V_{DD}$

Diagram 15: Drain-source breakdown voltage

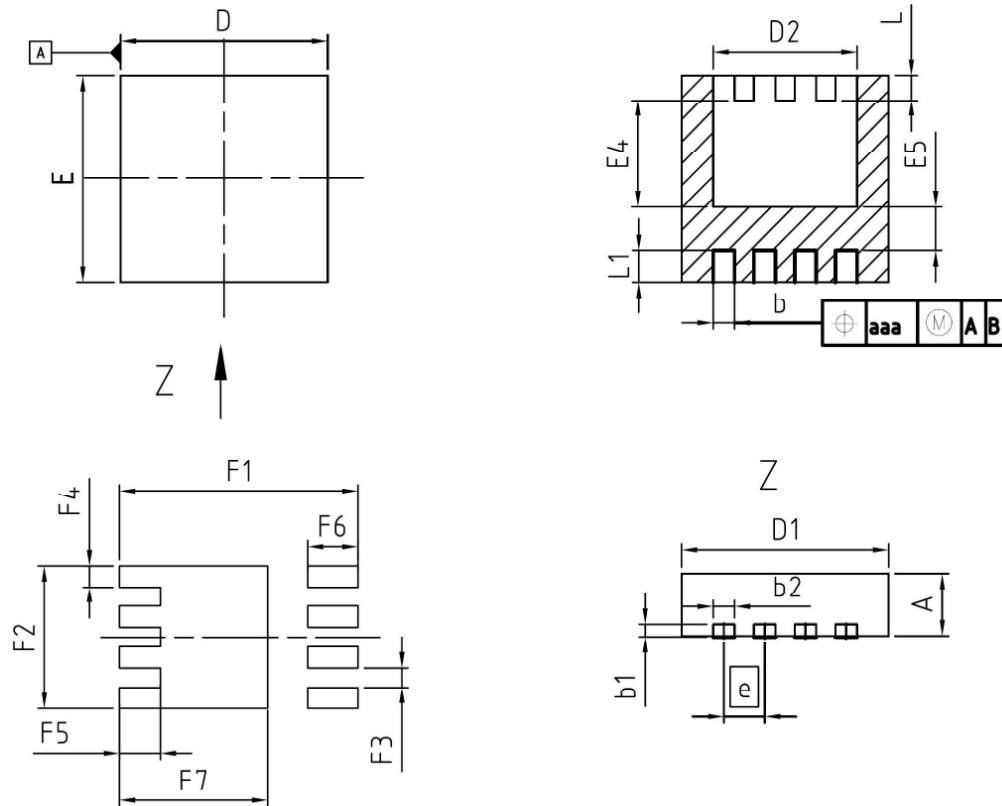


$V_{BR(DSS)}=f(T_j)$ ;  $I_D=1$  mA

Diagram Gate charge waveforms



## 5 Package Outlines



DIM	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.90	1.10	0.035	0.043
b	0.24	0.44	0.009	0.017
b1	0.10	0.30	0.004	0.012
b2	0.20	0.44	0.008	0.017
D=D1	3.20	3.40	0.126	0.134
D2	2.15	2.45	0.085	0.096
E	3.20	3.40	0.126	0.134
E4	1.60	1.81	0.063	0.071
E5	0.59	0.86	0.023	0.034
e	0.65		0.026	
N	8		8	
L	0.30	0.56	0.012	0.022
L1	0.33	0.60	0.013	0.024
aaa	0.25		0.010	
F1	3.80		0.150	
F2	2.29		0.090	
F3	0.31		0.012	
F4	0.34		0.013	
F5	0.65		0.026	
F6	0.80		0.031	
F7	2.36		0.093	

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Figure 1 Outline PG-TSDSON-8, dimensions in mm/inches

## Revision History

BSZ058N03LS G

**Revision: 2021-06-04, Rev. 2.1**

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.1	2021-06-04	Update Max Id current rating

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